Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/721,956	KIM, DUK-YONG	
Examiner	Art Unit	
Christian A. Hannon	2685	

	SEARCHED					
Class	Subclass	Date	Examiner			
455	561	2/16/06	H			
	562					
340	310.11					
	310.15		V			
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Consulted W/ Quadrien Vuona	41400	4	